

<b>Notice of References Cited</b>	Application/Control No. 10/611,978	Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner Tianjie Chen	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,715,121	02-1998	Sakakima et al.	360/324.2
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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